

M45PE80

8 Mbit, Low Voltage, Page-Erasable Serial Flash Memory With Byte-Alterability and a 25 MHz SPI Bus Interface

FEATURES SUMMARY

- 8Mbit of Page-Erasable Flash Memory
- Page Write (up to 256 Bytes) in 11ms (typical)
- Page Program (up to 256 Bytes) in 1.2ms (typical)
- Page Erase (256 Bytes) in 10ms (typical)
- Sector Erase (512 Kbit)
- 2.7 to 3.6V Single Supply Voltage
- SPI Bus Compatible Serial Interface
- 25MHz Clock Rate (maximum)
- Deep Power-down Mode 1µA (typical)
- Electronic Signature
 - JEDEC Standard Two-Byte Signature (4014h)
- More than 100,000 Write Cycles
- More than 20 Year Data Retention

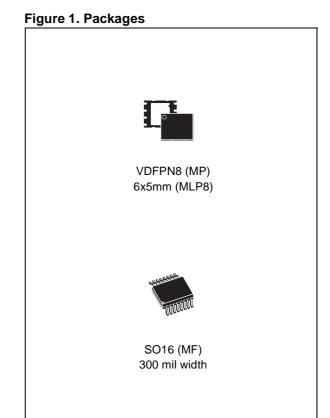


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SUMMARY DESCRIPTION

The M45PE80 is a 8Mbit (1M x 8 bit) Serial Paged Flash Memory accessed by a high speed SPIcompatible bus.

The memory can be written or programmed 1 to 256 bytes at a time, using the Page Write or Page Program instruction. The Page Write instruction consists of an integrated Page Erase cycle followed by a Page Program cycle.

The memory is organized as 16 sectors, each containing 256 pages. Each page is 256 bytes wide. Thus, the whole memory can be viewed as consisting of 4096 pages, or 1,048,576 bytes.

The memory can be erased a page at a time, using the Page Erase instruction, or a sector at a time, using the Sector Erase instruction.

Figure 2. Logic Diagram

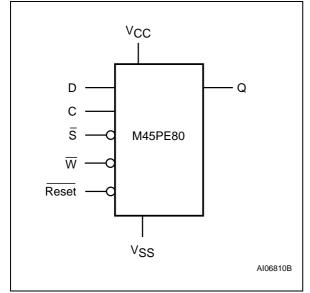
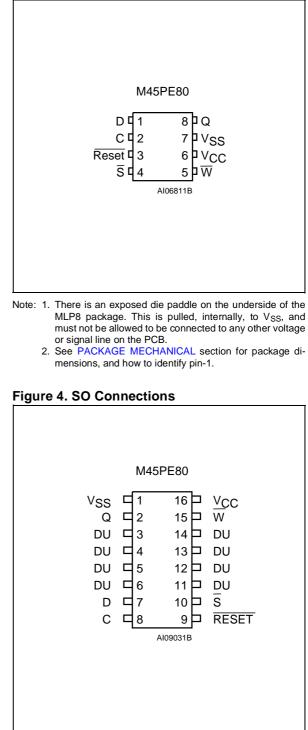


Table 1. Signal Names

U	
С	Serial Clock
D	Serial Data Input
Q	Serial Data Output
S	Chip Select
W	Write Protect
Reset	Reset
V _{CC}	Supply Voltage
a ∜ss t4U.com	Ground





Note: 1. DU = Don't Use

 See PACKAGE MECHANICAL section for package dimensions, and how to identify pin-1.

SIGNAL DESCRIPTION

Serial Data Output (Q). This output signal is used to transfer data serially out of the device. Data is shifted out on the falling edge of Serial Clock (C).

Serial Data Input (D). This input signal is used to transfer data serially into the device. It receives instructions, addresses, and the data to be programmed. Values are latched on the rising edge of Serial Clock (C).

Serial Clock (C). This input signal provides the timing of the serial interface. Instructions, addresses, or data present at Serial Data Input (D) are latched on the rising edge of Serial Clock (C). Data on Serial Data Output (Q) changes after the falling edge of Serial Clock (C).

Chip Select (S). When this input signal is High, the device is deselected and Serial Data Output (Q) is at high impedance. Unless an internal Read, Program, Erase or Write cycle is in progress, the device will be in the Standby mode (this is not the Deep Power-down mode). Driving Chip Select (\overline{S}) Low enables the device, placing it in the active power mode.

After Power-up, a falling edge on Chip Select (\overline{S}) is required prior to the start of any instruction.

Reset (Reset). The Reset (Reset) input provides a hardware reset for the memory. In this mode, the outputs are high impedance.

When Reset (Reset) is driven High, the memory is in the normal operating mode. When Reset (Reset) is driven Low, the memory will enter the Reset mode, provided that no internal <u>operation</u> is currently in progress. Driving Reset (Reset) Low while an internal operation is in progress has no effect on that internal operation (a write cycle, program cycle, or erase cycle).

Write Protect (\overline{W}). This input signal puts the device in the Hardware Protected mode, when Write Protect (\overline{W}) is connected to V_{SS}, causing the first 256 pages of memory to become read-only by protecting them from write, program and erase operations. When Write Protect (\overline{W}) is connected to V_{CC}, the first 256 pages of memory behave like the other pages of memory.



SPI MODES

These devices can be driven by a microcontroller with its SPI peripheral running in either of the two following modes:

- CPOL=0, CPHA=0
- CPOL=1, CPHA=1

For these two modes, input data is latched in on the rising edge of Serial Clock (C), and output data

is available from the falling edge of Serial Clock (C).

The difference between the two modes, as shown in Figure 6., is the clock polarity when the bus master is in Stand-by mode and not transferring data:

- C remains at 0 for (CPOL=0, CPHA=0)
- C remains at 1 for (CPOL=1, CPHA=1)

Figure 5. Bus Master and Memory Devices on the SPI Bus

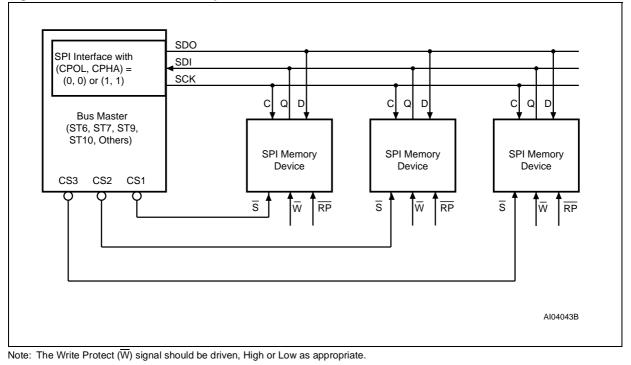
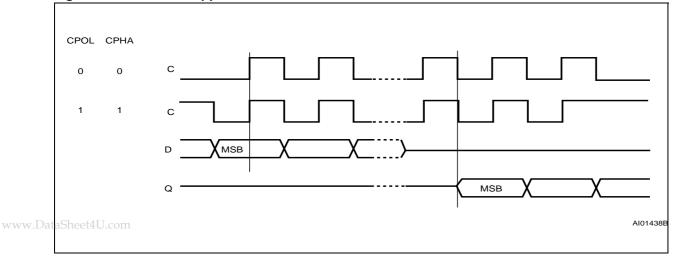


Figure 6. SPI Modes Supported





OPERATING FEATURES

Sharing the Overhead of Modifying Data

To write or program one (or more) data bytes, two instructions are required: Write Enable (WREN), which is one byte, and a Page Write (PW) or Page Program (PP) sequence, which consists of four bytes plus data. This is followed by the internal cycle (of duration t_{PW} or t_{PP}).

To share this overhead, the Page Write (PW) or Page Program (PP) instruction allows up to 256 bytes to be programmed (changing bits from 1 to 0) or written (changing bits to 0 or 1) at a time, provided that they lie in consecutive addresses on the same page of memory.

An Easy Way to Modify Data

The Page Write (PW) instruction provides a convenient way of modifying data (up to 256 contiguous bytes at a time), and simply requires the start address, and the new data in the instruction sequence.

The Page Write (PW) instruction is entered by driving Chip Select (\overline{S}) Low, and then transmitting the instruction byte, three address bytes (A23-A0) and at least one data byte, and then driving Chip Select (\overline{S}) High. While Chip Select (\overline{S}) is being held Low, the data bytes are written to the data buffer, starting at the address given in the third address byte (A7-A0). When Chip Select (\overline{S}) is driven High, the Write cycle starts. The remaining, unchanged, bytes of the data buffer are automatically loaded with the values of the corresponding bytes of the addressed memory page then automatically put into an Erase cycle. Finally, the addressed memory page is programmed with the contents of the data buffer.

All of this buffer management is handled internally, and is transparent to the user. The user is given the facility of being able to alter the contents of the memory on a byte-by-byte basis.

A Fast Way to Modify Data

The Page Program (PP) instruction provides a fast way of modifying data (up to 256 contiguous bytes at a time), provided that it only involves resetting bits to 0 that had previously been set to 1.

This might be:

- when the designer is programming the device for the first time
- when the designer knows that the page has already been erased by an earlier Page Erase (PE) or Sector Erase (SE) instruction. This is

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useful, for example, when storing a fast stream of data, having first performed the erase cycle when time was available

 when the designer knows that the only changes involve resetting bits to 0 that are still set to 1. When this method is possible, it has the additional advantage of minimising the number of unnecessary erase operations, and the extra stress incurred by each page.

Polling During a Write, Program or Erase Cycle

A further improvement in the write, program or erase time can be achieved by not waiting for the worst case delay (t_{PW} , t_{PP} , t_{PE} , or t_{SE}). The Write In Progress (WIP) bit is provided in the Status Register so that the application program can monitor its value, polling it to establish when the previous cycle is complete.

Reset

An internal Power-On Reset circuit helps protect against inadvertant data writes. Addition protection is provided by driving Reset (Reset) Low during the Power-on process, and only driving it High when V_{CC} has reached the correct voltage level, V_{CC} (min).

Active Power, Stand-by Power and Deep Power-Down Modes

When Chip Select (\overline{S}) is Low, the device is enabled, and in the Active Power mode.

When Chip Select (\overline{S}) is High, the device is disabled, but could remain in the Active Power mode until all internal cycles have completed (Program, Erase, Write). The device then goes in to the Stand-by Power mode. The device consumption drops to I_{CC1} .

The Deep Power-down mode is entered when the specific instruction (the Enter Deep Power-down Mode (DP) instruction) is executed. The device consumption drops further to I_{CC2} . The device remains in this mode until another specific instruction (the Release from Deep Power-down Mode and Read Electronic Signature (RES) instruction) is executed.

All other instructions are ignored while the device is in the Deep Power-down mode. This can be used as an extra software protection mechanism, when the device is not in active use, to protect the device from inadvertant Write, Program or Erase instructions.



Status Register

The Status Register contains two status bits that can be read by the Read Status Register (RDSR) instruction.

WIP bit. The Write In Progress (WIP) bit indicates whether the memory is busy with a Write, Program or Erase cycle.

WEL bit. The Write Enable Latch (WEL) bit indicates the status of the internal Write Enable Latch.

Table 2. Status Register Format

b7							b0
0	0	0	0	0	0	WEL	WIP

Note: 1. WEL and WIP are volatile read-only bits (WEL is set and reset by specific instructions; WIP is automatically set and reset by the internal logic of the device).

Protection Modes

The environments where non-volatile memory devices are used can be very noisy. No SPI device can operate correctly in the presence of excessive noise. To help combat this, the M45PE80 boasts the following data protection mechanisms:

- Power-On Reset and an internal timer (t_{PUW}) can provide protection against inadvertant changes while the power supply is outside the operating specification.
- Program, Erase and Write instructions are checked that they consist of a number of clock

pulses that is a multiple of eight, before they are accepted for execution.

- All instructions that modify data must be preceded by a Write Enable (WREN) instruction to set the Write Enable Latch (WEL) bit . This bit is returned to its reset state by the following events:
 - Power-up
 - Reset (RESET) driven Low
 - Write Disable (WRDI) instruction completion
 - Page Write (PW) instruction completion
 - Page Program (PP) instruction completion
 - Page Erase (PE) instruction completion
 - Sector Erase (SE) instruction completion
- The Hardware Protected mode is entered when Write Protect (W) is driven Low, causing the first 256 pages of memory to become read-only. When Write Protect (W) is driven High, the first 256 pages of memory behave like the other pages of memory
- The Reset (Reset) signal can be driven Low to protect the contents of the memory during any critical time, not just during Power-up and Power-down.
- In addition to the low power consumption feature, the Deep Power-down mode offers extra software protection from inadvertant Write, Program and Erase instructions while the device is not in active use.



MEMORY ORGANIZATION

The memory is organized as:

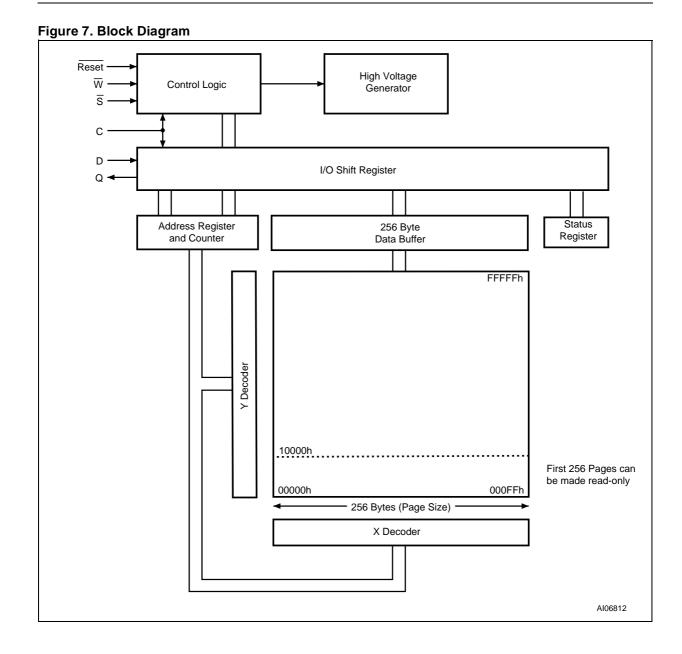
- 4096 pages (256 bytes each).
- 1,048,576 bytes (8 bits each)
- 16 sectors (512 Kbits, 65536 bytes each)
- Each page can be individually:
- programmed (bits are programmed from 1 to 0)
- erased (bits are erased from 0 to 1)
- written (bits are changed to either 0 or 1)

The device is Page or Sector Erasable (bits are erased from 0 to 1).

Table 3. Memory Organization

Sector	Address Range			
15	F0000h	FFFFh		
14	E0000h	EFFFFh		
13	D0000h	DFFFFh		
12	C0000h	CFFFFh		
11	B0000h	BFFFFh		
10	A0000h	AFFFFh		
9	90000h	9FFFFh		
8	80000h	8FFFFh		
7	70000h	7FFFFh		
6	60000h	6FFFFh		
5	50000h	5FFFFh		
4	40000h	4FFFFh		
3	30000h	3FFFFh		
2	20000h	2FFFFh		
1	10000h	1FFFFh		
0	00000h	0FFFFh		





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INSTRUCTIONS

All instructions, addresses and data are shifted in and out of the device, most significant bit first.

Serial Data Input (D) is sampled on the first rising edge of Serial Clock (C) after Chip Select (\overline{S}) is driven Low. Then, the one-byte instruction code must be shifted in to the device, most significant bit first, on Serial Data Input (D), each bit being latched on the rising edges of Serial Clock (C).

The instruction set is listed in Table 4..

Every instruction sequence starts with a one-byte instruction code. Depending on the instruction, this might be followed by address bytes, or by data bytes, or by both or none.

In the case of a Read Data Bytes (READ), Read Data Bytes at Higher Speed (Fast_Read) or Read Status Register (RDSR) instruction, the shifted-in instruction sequence is followed by a data-out se-

quence. Chip Select (\overline{S}) can be driven High after any bit of the data-out sequence is being shifted out.

In the case of a Page Write (PW), Page Program (PP), Page Erase (PE), Sector Erase (SE), Write Enable (WREN), Write Disable (WRDI), Deep Power-down (DP) or Release from Deep Power-down (RDP) instruction, Chip Select (\overline{S}) must be driven High exactly at a byte boundary, otherwise the instruction is rejected, and is not executed. That is, Chip Select (\overline{S}) must driven High when the number of clock pulses after Chip Select (\overline{S}) being driven Low is an exact multiple of eight.

All attempts to access the memory array during a Write cycle, Program cycle or Erase cycle are ignored, and the internal Write cycle, Program cycle or Erase cycle continues unaffected.

Instruction	Description	One-byte Instruction Code		Address Bytes	Dummy Bytes	Data Bytes
WREN	Write Enable	0000 0110	06h	0	0	0
WRDI	Write Disable	0000 0100	04h	0	0	0
RDID	Read Identification	1001 1111	9Fh	0	0	1 to 3
RDSR	Read Status Register	0000 0101	05h	0	0	1 to ∞
READ	Read Data Bytes	0000 0011	03h	3	0	1 to ∞
FAST_READ	Read Data Bytes at Higher Speed	0000 1011	0Bh	3	1	1 to ∞
PW	Page Write	0000 1010	0Ah	3	0	1 to 256
PP	Page Program	0000 0010	02h	3	0	1 to 256
PE	Page Erase	1101 1011	DBh	3	0	0
SE	Sector Erase	1101 1000	D8h	3	0	0
DP	Deep Power-down	1011 1001	B9h	0	0	0
RDP	Release from Deep Power-down	1010 1011	ABh	0	0	0



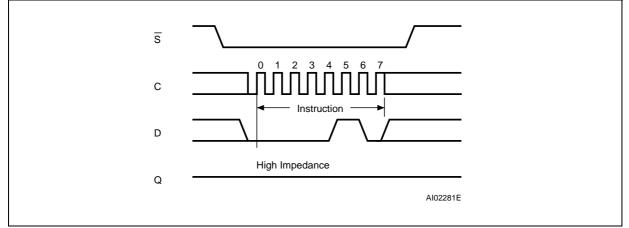
Write Enable (WREN)

The Write Enable (WREN) instruction (Figure 8.) sets the Write Enable Latch (WEL) bit.

The Write Enable Latch (WEL) bit must be set prior to every Page Write (PW), Page Program (PP), Page Erase (PE), and Sector Erase (SE) instruction.

The Write Enable (WREN) instruction is entered by driving Chip Select (\overline{S}) Low, sending the instruction code, and then driving Chip Select (\overline{S}) High.





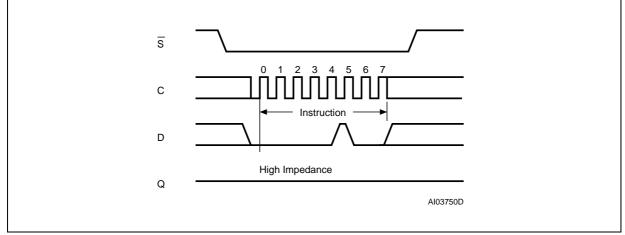
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Write Disable (WRDI)

The Write Disable (WRDI) instruction (Figure 9.) resets the Write Enable Latch (WEL) bit. The Write Disable (WRDI) instruction is entered by driving Chip Select (\overline{S}) Low, sending the instruction code, and then driving Chip Select (\overline{S}) High. The Write Enable Latch (WEL) bit is reset under the following conditions: Power-up

- Write Disable (WRDI) instruction completion
- Page Write (PW) instruction completion
- Page Program (PP) instruction completion
- Page Erase (PE) instruction completion
- Sector Erase (SE) instruction completion







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Read Identification (RDID)

The Read Identification (RDID) instruction allows the 8-bit manufacturer identification to be read, followed by two bytes of device identification. The manufacturer identification is assigned by JEDEC, and has the value 20h for STMicroelectronics. The device identification is assigned by the device manufacturer, and indicates the memory type in the first byte (40h), and the memory capacity of the device in the second byte (14h).

Any Read Identification (RDID) instruction while an Erase or Program cycle is in progress, is not decoded, and has no effect on the cycle that is in progress.

The device is first selected by driving Chip Select $\overline{(S)}$ Low. Then, the 8-bit instruction code for the in-

struction is shifted in. This is followed by the 24-bit device identification, stored in the memory, being shifted out on Serial Data Output (Q), each bit being shifted out during the falling edge of Serial Clock (C).

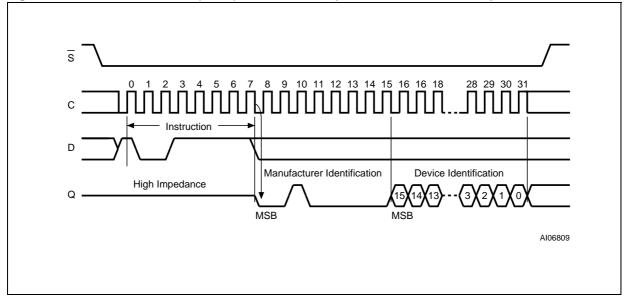
The instruction sequence is shown in Figure 10..

The Read Identification (RDID) instruction is terminated by driving Chip Select (\overline{S}) High at any time during data output.

When Chip Select (\overline{S}) is driven High, the device is put in the Stand-by Power mode. Once in the Stand-by Power mode, the device waits to be selected, so that it can receive, decode and execute instructions.

Manufacturer Identification	Device Identification		
	Memory Type	Memory Capacity	
20h	40h	14h	

Figure 10. Read Identification (RDID) Instruction Sequence and Data-Out Sequence



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Read Status Register (RDSR)

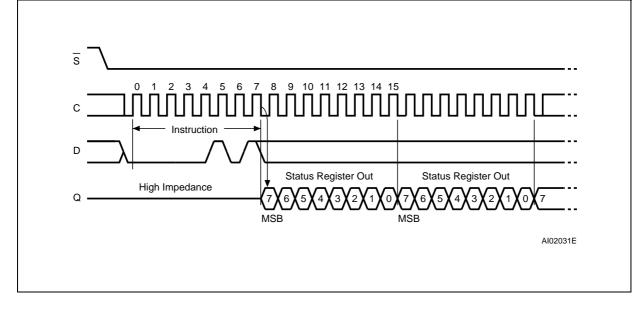
The Read Status Register (RDSR) instruction allows the Status Register to be read. The Status Register may be read at any time, even while a Program, Erase or Write cycle is in progress. When one of these cycles is in progress, it is recommended to check the Write In Progress (WIP) bit before sending a new instruction to the device. It is also possible to read the Status Register continuously, as shown in Figure 11..

The status bits of the Status Register are as follows:

WIP bit. The Write In Progress (WIP) bit indicates whether the memory is busy with a Write, Program or Erase cycle. When set to 1, such a cycle is in progress, when reset to 0 no such cycle is in progress.

WEL bit. The Write Enable Latch (WEL) bit indicates the status of the internal Write Enable Latch. When set to 1 the internal Write Enable Latch is set, when set to 0 the internal Write Enable Latch is reset and no Write, Program or Erase instruction is accepted.





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Read Data Bytes (READ)

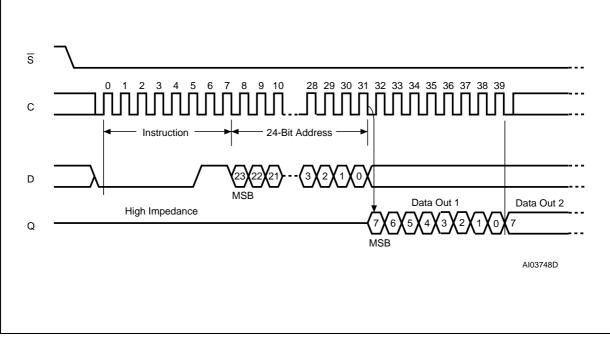
The device is first selected by driving Chip Select (\overline{S}) Low. The instruction code for the Read Data Bytes (READ) instruction is followed by a 3-byte address (A23-A0), each bit being latched-in during the rising edge of Serial Clock (C). Then the memory contents, at that address, is shifted out on Serial Data Output (Q), each bit being shifted out, at a maximum frequency f_R , during the falling edge of Serial Clock (C).

The instruction sequence is shown in Figure 12..

The first byte addressed can be at any location. The address is automatically incremented to the next higher address after each byte of data is shifted out. The whole memory can, therefore, be read with a single Read Data Bytes (READ) instruction. When the highest address is reached, the address counter rolls over to 000000h, allowing the read sequence to be continued indefinitely.

The Read Data Bytes (READ) instruction is terminated by driving Chip Select (\overline{S}) High. Chip Select (\overline{S}) can be driven High at any time during data output. Any Read Data Bytes (READ) instruction, while an Erase, Program or Write cycle is in progress, is rejected without having any effects on the cycle that is in progress.





Note: Address bits A23 to A20 are Don't Care.

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Read Data Bytes at Higher Speed (FAST_READ)

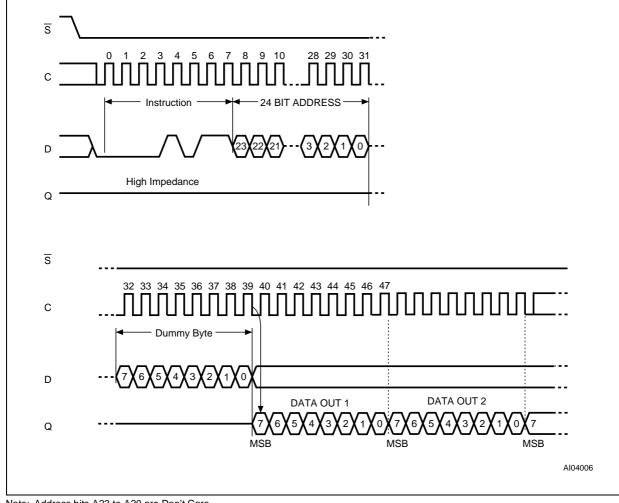
The device is first selected by driving Chip Select (\overline{S}) Low. The instruction code for the Read Data Bytes at Higher Speed (FAST_READ) instruction is followed by a 3-byte address (A23-A0) and a dummy byte, each bit being latched-in during the rising edge of Serial Clock (C). Then the memory contents, at that address, is shifted out on Serial Data Output (Q), each bit being shifted out, at a maximum frequency f_C , during the falling edge of Serial Clock (C).

The instruction sequence is shown in Figure 13..

The first byte addressed can be at any location. The address is automatically incremented to the next higher address after each byte of data is shifted out. The whole memory can, therefore, be read with a single Read Data Bytes at Higher Speed (FAST_READ) instruction. When the highest address is reached, the address counter rolls over to 000000h, allowing the read sequence to be continued indefinitely.

The Read Data Bytes at Higher Speed (FAST_READ) instruction is terminated by driving Chip Select (\overline{S}) High. Chip Select (\overline{S}) can be driven High at any time during data output. Any Read Data Bytes at Higher Speed (FAST_READ) instruction, while an Erase, Program or Write cycle is in progress, is rejected without having any effects on the cycle that is in progress.





Note: Address bits A23 to A20 are Don't Care.

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Page Write (PW)

The Page Write (PW) instruction allows bytes to be written in the memory. Before it can be accepted, a Write Enable (WREN) instruction must previously have been executed. After the Write Enable (WREN) instruction has been decoded, the device sets the Write Enable Latch (WEL).

The Page Write (PW) instruction is entered by driving Chip Select (S) Low, followed by the instruction code, three address bytes and at least one data byte on Serial Data Input (D). The rest of the page remains unchanged if no power failure occurs during this write cycle.

The Page Write (PW) instruction performs a page erase cycle even if only one byte is updated.

If the 8 least significant address bits (A7-A0) are not all zero, all transmitted data exceeding the addressed page boundary roll over, and are written from the start address of the same page (the one whose 8 least significant address bits (A7-A0) are all zero). Chip Select (\overline{S}) must be driven Low for the entire duration of the sequence.

The instruction sequence is shown in Figure 14..

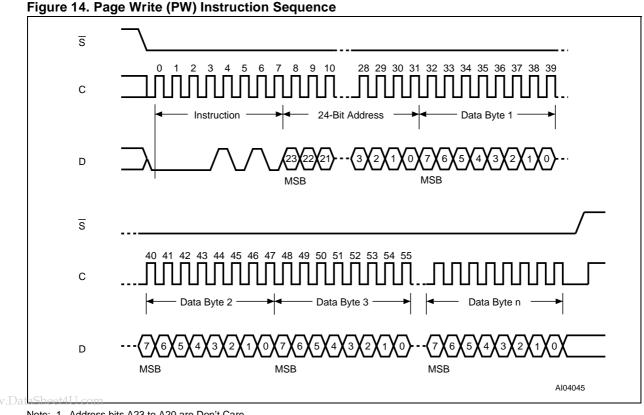
If more than 256 bytes are sent to the device, previously latched data are discarded and the last 256 data bytes are guaranteed to be written correctly within the same page. If less than 256 Data bytes are sent to device, they are correctly written at the requested addresses without having any effects on the other bytes of the same page.

Chip Select (\overline{S}) must be driven High after the eighth bit of the last data byte has been latched in, otherwise the Page Write (PW) instruction is not executed.

As soon as Chip Select (\overline{S}) is driven High, the selftimed Page Write cycle (whose duration is t_{PW}) is initiated. While the Page Write cycle is in progress, the Status Register may be read to check the value of the Write In Progress (WIP) bit. The Write In Progress (WIP) bit is 1 during the self-timed Page Write cycle, and is 0 when it is completed. At some unspecified time before the cycle is complete, the Write Enable Latch (WEL) bit is reset.

A Page Write (PW) instruction applied to a page that is Hardware Protected is not executed.

Any Page Write (PW) instruction, while an Erase, Program or Write cycle is in progress, is rejected without having any effects on the cycle that is in progress.



Note: 1. Address bits A23 to A20 are Don't Care 2. $1 \le n \le 256$

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Page Program (PP)

The Page Program (PP) instruction allows bytes to be programmed in the memory (changing bits from 1 to 0, only). Before it can be accepted, a Write Enable (WREN) instruction must previously have been executed. After the Write Enable (WREN) instruction has been decoded, the device sets the Write Enable Latch (WEL).

The Page Program (PP) instruction is entered by driving Chip Select (\overline{S}) Low, followed by the instruction code, three address bytes and at least one data byte on Serial Data Input (D). If the 8 least significant address bits (A7-A0) are not all zero, all transmitted data exceeding the addressed page boundary roll over, and are programmed from the start address of the same page (the one whose 8 least significant address bits (A7-A0) are all zero). Chip Select (\overline{S}) must be driven Low for the entire duration of the sequence.

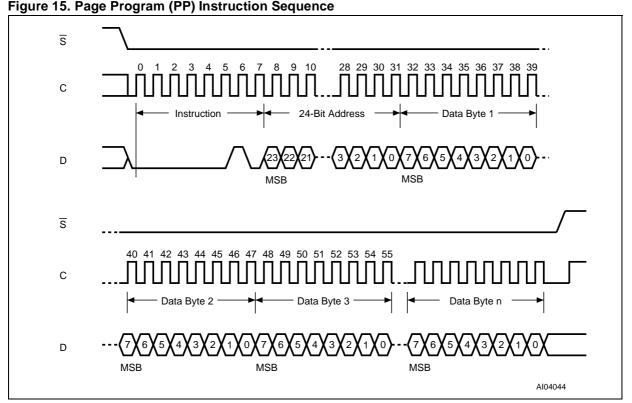
The instruction sequence is shown in Figure 15..

If more than 256 bytes are sent to the device, previously latched data are discarded and the last 256 data bytes are guaranteed to be programmed correctly within the same page. If less than 256 Data bytes are sent to device, they are correctly programmed at the requested addresses without having any effects on the other bytes of the same page.

Chip Select (\overline{S}) must be driven High after the eighth bit of the last data byte has been latched in, otherwise the Page Program (PP) instruction is not executed.

As soon as Chip Select (\overline{S}) is driven High, the selftimed Page Program cycle (whose duration is t_{PP}) is initiated. While the Page Program cycle is in progress, the Status Register may be read to check the value of the Write In Progress (WIP) bit. The Write In Progress (WIP) bit is 1 during the selftimed Page Program cycle, and is 0 when it is completed. At some unspecified time before the cycle is complete, the Write Enable Latch (WEL) bit is reset.

A Page Program (PP) instruction applied to a page that is Hardware Protected is not executed. Any Page Program (PP) instruction, while an Erase, Program or Write cycle is in progress, is rejected without having any effects on the cycle that is in progress.



Note: 1. Address bits A23 to A20 are Don't Care www.DataShec241 \leq m \leq 256



M45PE80

Page Erase (PE)

The Page Erase (PE) instruction sets to 1 (FFh) all bits inside the chosen page. Before it can be accepted, a Write Enable (WREN) instruction must previously have been executed. After the Write Enable (WREN) instruction has been decoded, the device sets the Write Enable Latch (WEL).

The Page Erase (PE) instruction is entered by driving Chip Select (\overline{S}) Low, followed by the instruction code, and three address bytes on Serial Data Input (D). Any address inside the Page is a valid address for the Page Erase (PE) instruction. Chip Select (\overline{S}) must be driven Low for the entire duration of the sequence.

The instruction sequence is shown in Figure 16..

Chip Select (\overline{S}) must be driven High after the eighth bit of the last address byte has been latched

in, otherwise the Page Erase (PE) instruction is not executed. As soon as Chip Select (\overline{S}) is driven High, the self-timed Page Erase cycle (whose duration is t_{PE}) is initiated. While the Page Erase cycle is in progress, the Status Register may be read to check the value of the Write In Progress (WIP) bit. The Write In Progress (WIP) bit is 1 during the self-timed Page Erase cycle, and is 0 when it is completed. At some unspecified time before the cycle is complete, the Write Enable Latch (WEL) bit is reset.

A Page Erase (PE) instruction applied to a page that is Hardware Protected is not executed.

Any Page Erase (PE) instruction, while an Erase, Program or Write cycle is in progress, is rejected without having any effects on the cycle that is in progress.

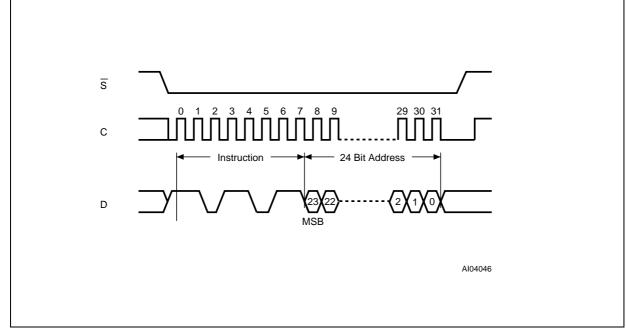


Figure 16. Page Erase (PE) Instruction Sequence

Note: Address bits A23 to A20 are Don't Care.

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Sector Erase (SE)

The Sector Erase (SE) instruction sets to 1 (FFh) all bits inside the chosen sector. Before it can be accepted, a Write Enable (WREN) instruction must previously have been executed. After the Write Enable (WREN) instruction has been decoded, the device sets the Write Enable Latch (WEL).

The Sector Erase (SE) instruction is entered by driving Chip Select (\overline{S}) Low, followed by the instruction code, and three address bytes on Serial Data Input (D). Any address inside the Sector (see Table 3.) is a valid address for the Sector Erase (SE) instruction. Chip Select (\overline{S}) must be driven Low for the entire duration of the sequence.

The instruction sequence is shown in Figure 17..

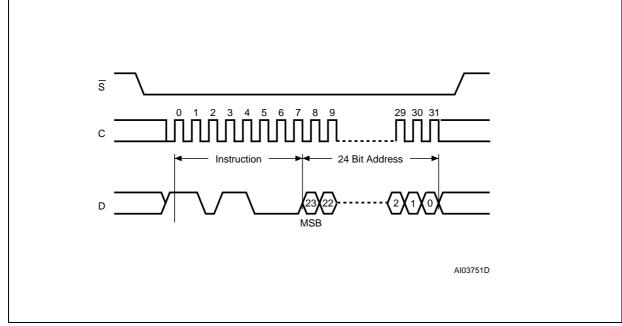
Chip Select (\overline{S}) must be driven High after the eighth bit of the last address byte has been latched in, otherwise the Sector Erase (SE) instruction is

Figure 17. Sector Erase (SE) Instruction Sequence

not executed. As soon as Chip Select (\overline{S}) is driven High, the self-timed Sector Erase cycle (whose duration is t_{SE}) is initiated. While the Sector Erase cycle is in progress, the Status Register may be read to check the value of the Write In Progress (WIP) bit. The Write In Progress (WIP) bit is 1 during the self-timed Sector Erase cycle, and is 0 when it is completed. At some unspecified time before the cycle is complete, the Write Enable Latch (WEL) bit is reset.

A Sector Erase (SE) instruction applied to a sector that contains a page that is Hardware Protected is not executed.

Any Sector Erase (SE) instruction, while an Erase, Program or Write cycle is in progress, is rejected without having any effects on the cycle that is in progress.



Note: Address bits A23 to A20 are Don't Care.

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Deep Power-down (DP)

Executing the Deep Power-down (DP) instruction is the only way to put the device in the lowest consumption mode (the Deep Power-down mode). It can also be used as an extra software protection mechanism, while the device is not in active use, since in this mode, the device ignores all Write, Program and Erase instructions.

Driving Chip Select (\overline{S}) High deselects the device, and puts the device in the Standby mode (if there is no internal cycle currently in progress). But this mode is not the Deep Power-down mode. The Deep Power-down mode can only be entered by executing the Deep Power-down (DP) instruction, to reduce the standby current (from I_{CC1} to I_{CC2}, as specified in Table 11.).

Once the device has entered the Deep Powerdown mode, all instructions are ignored except the Release from Deep Power-down (RDP) instruction. This releases the device from this mode. The Deep Power-down mode automatically stops at Power-down, and the device always Powers-up in the Standby mode.

The Deep Power-down (DP) instruction is entered by driving Chip Select (\overline{S}) Low, followed by the instruction code on Serial Data Input (D). Chip Select (\overline{S}) must be driven Low for the entire duration of the sequence.

The instruction sequence is shown in Figure 18..

Chip Select (\overline{S}) must be driven High after the eighth bit of the instruction code has been latched in, otherwise the Deep Power-down (DP) instruction is not executed. As soon as Chip Select (\overline{S}) is driven High, it requires a delay of t_{DP} before the supply current is reduced to I_{CC2} and the Deep Power-down mode is entered.

Any Deep Power-down (DP) instruction, while an Erase, Program or Write cycle is in progress, is rejected without having any effects on the cycle that is in progress.

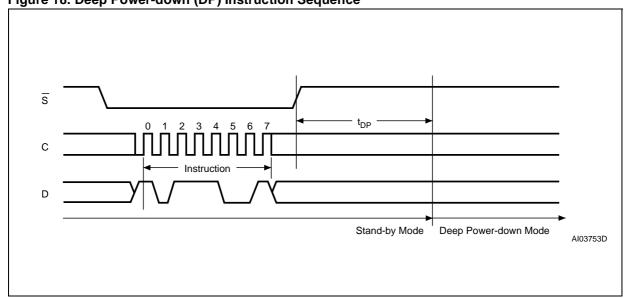


Figure 18. Deep Power-down (DP) Instruction Sequence

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Release from Deep Power-down (RDP)

Once the device has entered the Deep Powerdown mode, all instructions are ignored except the Release from Deep Power-down (RDP) instruction. Executing this instruction takes the device out of the Deep Power-down mode.

The Release from Deep Power-down (RDP) instruction is entered by driving Chip Select (\overline{S}) Low, followed by the instruction code on Serial Data Input (D). Chip Select (\overline{S}) must be driven Low for the entire duration of the sequence.

The instruction sequence is shown in Figure 19..

The Release from Deep Power-down (RDP) instruction is terminated by driving Chip Select (\overline{S}) High. Sending additional clock cycles on Serial Clock (C), while Chip Select (\overline{S}) is driven Low, cause the instruction to be rejected, and not executed.

After Chip Select (\overline{S}) has been driven High, followed by a delay, t_{RDP} , the device is put in the Standby mode. Chip Select (\overline{S}) must remain High at least until this period is over. The device waits to be selected, so that it can receive, decode and execute instructions.

Any Release from Deep Power-down (RDP) instruction, while an Erase, Program or Write cycle is in progress, is rejected without having any effects on the cycle that is in progress.

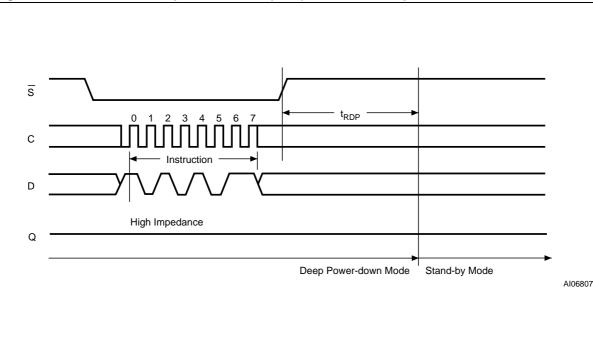


Figure 19. Release from Deep Power-down (RDP) Instruction Sequence

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POWER-UP AND POWER-DOWN

At Power-up and Power-down, the device must not be selected (that is Chip Select (\overline{S}) must follow the voltage applied on V_{CC}) until V_{CC} reaches the correct value:

- V_{CC}(min) at Power-up, and then for a further delay of t_{VSL}
- V_{SS} at Power-down

Usually a simple pull-up resistor on Chip Select (\overline{S}) can be used to insure safe and proper Power-up and Power-down.

To avoid data corruption and inadvertent write operations during power up, a Power On Reset (POR) circuit is included. The logic inside the device is held reset while V_{CC} is less than the POR threshold value, V_{WI} – all operations are disabled, and the device does not respond to any instruction.

Moreover, the device ignores all Write Enable (WREN), Page Write (PW), Page Program (PP), Page Erase (PE) and Sector Erase (SE) instructions until a time delay of t_{PUW} has elapsed after the moment that V_{CC} rises above the V_{WI} threshold. However, the correct operation of the device is not guaranteed if, by this time, V_{CC} is still below V_{CC} (min). No Write, Program or Erase instructions should be sent until the later of:

- t_{PUW} after V_{CC} passed the V_{WI} threshold
- t_{VSL} after V_{CC} passed the V_{CC}(min) level

These values are specified in Table 6...

If the delay, t_{VSL} , has elapsed, after V_{CC} has risen above V_{CC} (min), the device can be selected for READ instructions even if the t_{PUW} delay is not yet fully elapsed.

As an extra protection, the Reset ($\overline{\text{Reset}}$) signal could be driven Low for the whole duration of the Power-up and Power-down phases.

At Power-up, the device is in the following state:

- The device is in the Standby mode (not the Deep Power-down mode).
- The Write Enable Latch (WEL) bit is reset.

Normal precautions must be taken for supply rail decoupling, to stablise the V_{CC} feed. Each device in a system should have the V_{CC} rail decoupled by a suitable capacitor close to the package pins. (Generally, this capacitor is of the order of 0.1μ F).

At Power-down, when V_{CC} drops from the operating voltage, to below the POR threshold value, V_{WI} , all operations are disabled and the device does not respond to any instruction. (The designer needs to be aware that if a Power-down occurs while a Write, Program or Erase cycle is in progress, some data corruption can result.)

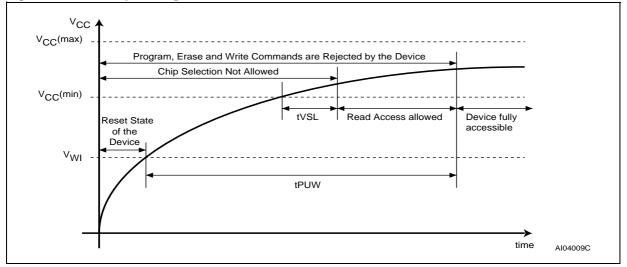


Figure 20. Power-up Timing

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Table 6. Power-Up Timing and V_{WI} Threshold

Symbol	Parameter	Min.	Max.	Unit
t _{VSL} 1	$V_{CC}(min)$ to \overline{S} low	30		μs
t _{PUW} 1	Time delay before the first Write, Program or Erase instruction	1	10	ms
V _{WI} ¹	Write Inhibit Voltage	1.5	2.5	V

Note: 1. These parameters are characterized only, over the temperature range -40°C to +85°C.

INITIAL DELIVERY STATE

The device is delivered with the memory array erased: all bits are set to 1 (each byte contains FFh). All usable Status Register bits are 0.



MAXIMUM RATING

Stressing the device above the rating listed in the Absolute Maximum Ratings table may cause permanent damage to the device. These are stress ratings only and operation of the device at these or any other conditions above those indicated in the Operating sections of this specification is not implied. Exposure to Absolute Maximum Rating conditions for extended periods may affect device reliability. Refer also to the STMicroelectronics SURE Program and other relevant quality documents.

Table 7. Absolute Maximum Ratings

Symbol	Parameter	Min.	Max.	Unit
T _{STG}	Storage Temperature	age Temperature -65 150		°C
T _{LEAD}	Lead Temperature during Soldering	See note ¹		°C
V _{IO}	Input and Output Voltage (with respect to Ground)	-0.6	4.0	V
V _{CC}	Supply Voltage	-0.6	4.0	V
V _{ESD}	Electrostatic Discharge Voltage (Human Body model) ²	-2000	2000	V

Note: 1. Compliant with JEDEC Std J-STD-020B (for small body, Sn-Pb or Pb assembly), the ST ECOPACK[®] 7191395 specification, and the European directive on Restrictions on Hazardous Substances (RoHS) 2002/95/EU

2. JEDEC Std JESD22-A114A (C1=100 pF, R1=1500 Ω , R2=500 Ω)



DC AND AC PARAMETERS

This section summarizes the operating and measurement conditions, and the DC and AC characteristics of the device. The parameters in the DC and AC Characteristic tables that follow are derived from tests performed under the Measurement Conditions summarized in the relevant tables. Designers should check that the operating conditions in their circuit match the measurement conditions when relying on the quoted parameters.

Table 8. Operating Conditions

Symbol	Parameter	Min.	Max.	Unit
Vcc	Supply Voltage	2.7	3.6	V
T _A	Ambient Operating Temperature	-40	85	°C

Table 9. AC Measurement Conditions

Symbol	Parameter Min. Max. U					
CL	Load Capacitance	30 pł				
	Input Rise and Fall Times	5				
	Input Pulse Voltages	0.2V _{CC} to 0.8V _{CC} V				
	Input and Output Timing Reference Voltages	0.3V _{CC} to 0.7V _{CC} V				

Note: Output Hi-Z is defined as the point where data out is no longer driven.

Figure 21. AC Measurement I/O Waveform

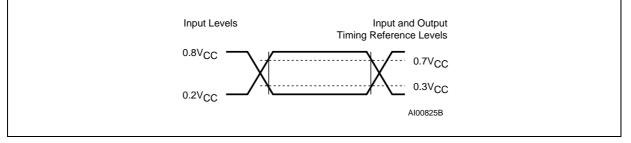


Table 10. Capacitance

Symbol	Parameter Test Condition Min.		Min.	Max.	Unit
C _{OUT}	Output Capacitance (Q)	$V_{OUT} = 0V$		8	pF
C _{IN}	Input Capacitance (other pins)	$V_{IN} = 0V$		6	pF

Note: Sampled only, not 100% tested, at $T_A{=}25^\circ\text{C}$ and a frequency of 20 MHz.

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Table	11.	DC	Characteristics
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Symbol	Parameter	Test Condition (in addition to those in Table 8.)		Max.	Unit
ILI	Input Leakage Current			± 2	μA
I _{LO}	Output Leakage Current			± 2	μA
I _{CC1}	Standby Current (Standby and Reset modes)	$\overline{S} = V_{CC}, V_{IN} = V_{SS} \text{ or } V_{CC}$		50	μA
I _{CC2}	Deep Power-down Current	$\overline{S} = V_{CC}, V_{IN} = V_{SS} \text{ or } V_{CC}$		10	μA
I _{CC3}	Operating Current (FAST_READ)	$\label{eq:C} \begin{array}{l} C = 0.1 V_{CC} / 0.9. V_{CC} \text{ at } 25 \text{ MHz}, \\ Q = \text{open} \end{array}$		6	mA
I _{CC4}	Operating Current (PW)	$\overline{S} = V_{CC}$		15	mA
I _{CC5}	Operating Current (SE)	$\overline{S} = V_{CC}$		15	mA
VIL	Input Low Voltage		- 0.5	0.3V _{CC}	V
V _{IH}	Input High Voltage		0.7V _{CC}	V _{CC} +0.4	V
V _{OL}	Output Low Voltage	I _{OL} = 1.6 mA		0.4	V
V _{OH}	Output High Voltage	I _{OH} = −100 μA	V _{CC} -0.2		V



Symbol	Alt.	Parameter	Min.	Тур.	Max.	Unit
fc	fc	Clock Frequency for the following instructions: FAST_READ, PW, PP, PE, SE, DP, RDP, WREN, WRDI, RDSR	D.C.	Typ.	25	MHz
f _R		Clock Frequency for READ instructions	D.C.		20	MHz
t _{CH} ¹	t CLH	Clock High Time	18			ns
t _{CL} ¹	tCLL	Clock Low Time	18			ns
		Clock Slew Rate ² (peak to peak)	0.03			V/ns
t _{SLCH}	t _{CSS}	\overline{S} Active Setup Time (relative to C)	10			ns
t _{CHSL}		S Not Active Hold Time (relative to C)	10			ns
t _{DVCH}	tDSU	Data In Setup Time	5			ns
t _{CHDX}	t _{DH}	Data In Hold Time	5			ns
tCHSH		S Active Hold Time (relative to C)	10			ns
tSHCH		S Not Active Setup Time (relative to C)	10			ns
tSHSL	tCSH	S Deselect Time	200			ns
t _{SHQZ} ²	t _{DIS}	Output Disable Time			15	ns
tCLQV	t _V	Clock Low to Output Valid			15	ns
t _{CLQX}	t _{HO}	Output Hold Time	0			ns
t _{RLRH} ²	t _{RST}	Reset Pulse Width	10			μs
t _{RHSL}	t _{REC}	Reset Recovery Time			3	μs
^t SHRH		Chip should have been deselected before Reset is de-asserted	10			ns
twhsl		Write Protect Setup Time	50			ns
tSHWL		Write Protect Hold Time	100			ns
t _{DP} ²		S to Deep Power-down			3	μs
t _{RDP} ²		S High to Standby Mode			30	μs
t _{PW}		Page Write Cycle Time		11	25	ms
tpp		Page Program Cycle Time		1.2	5	ms
t _{PE}		Page Erase Cycle Time		10	20	ms
tse		Sector Erase Cycle Time		1	5	s

Table 12. AC Characteristics

Note: 1. t_{CH} + t_{CL} must be greater than or equal to 1/ f_C 2. Value guaranteed by characterization, not 100% tested in production.

M45PE80

Figure 22. Serial Input Timing

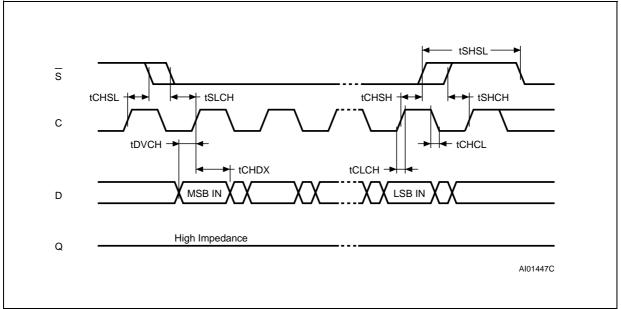
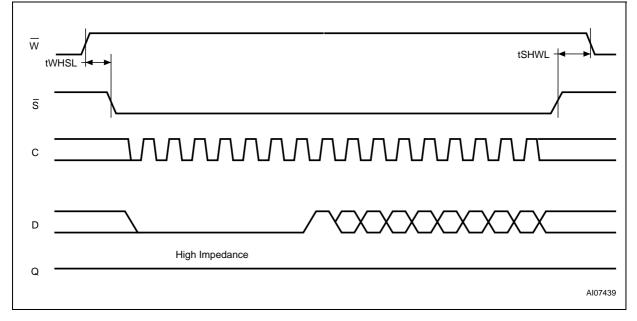


Figure 23. Write Protect Setup and Hold Timing



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Figure 24. Output Timing

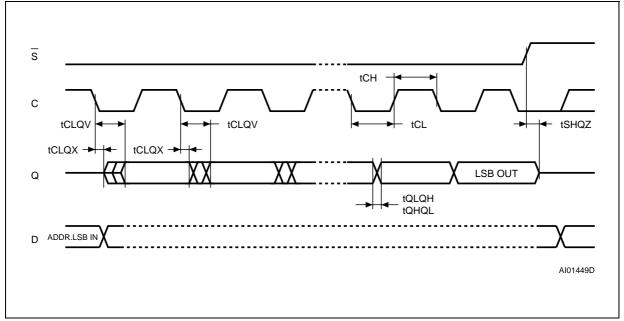
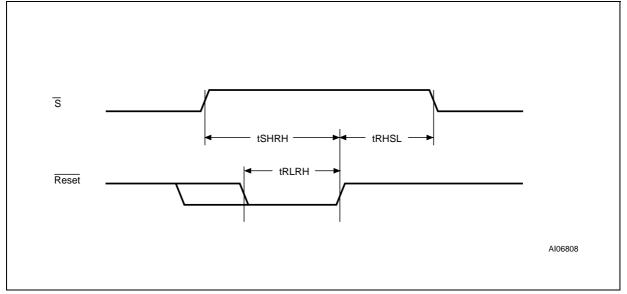


Figure 25. Reset AC Waveforms

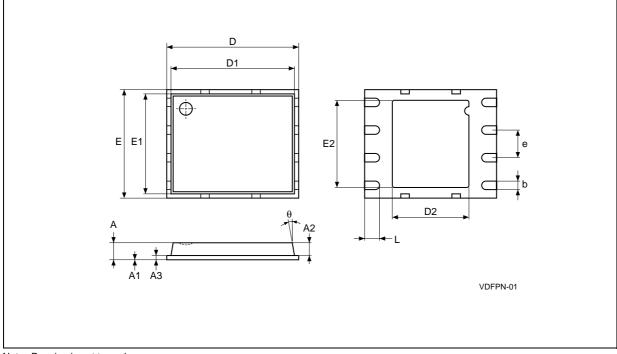


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PACKAGE MECHANICAL

Figure 26. MLP8, 8-lead Very thin Dual Flat Package No lead, 6x5mm, Package Outline



Note: Drawing is not to scale.

	8-lead Very thin Dual Flat Package No le	
		inches

Comple		mm			inches	
Symb.	Тур.	Min.	Max.	Тур.	Min.	Max.
A	0.85		1.00	0.0335		0.0394
A1		0.00	0.05		0.0000	0.0020
A2	0.65			0.0256		
A3	0.20			0.0079		
b	0.40	0.35	0.48	0.0157	0.0138	0.0189
D	6.00			0.2362		
D1	5.75			0.2264		
D2	3.40	3.20	3.60	0.1339	0.1260	0.1417
E	5.00			0.1969		
E1	4.75			0.1870		
E2	4.00	3.80	4.20	0.1575	0.1496	0.1654
e	1.27			0.0500		
L	0.60	0.50	0.75	0.0236	0.0197	0.0295
at aSheet40.com Ø			12°			12°

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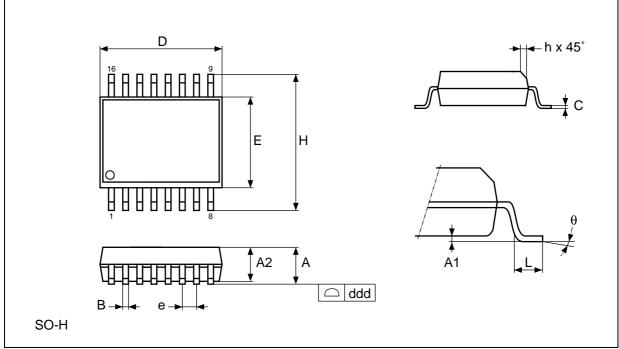


Figure 27. SO16 wide - 16-lead Plastic Small Outline, 300 mils body width, Package Outline

Note: Drawing is not to scale.

Table 14. SO16 wide - 16-lead Plastic Small Outline, 300 mils body width, Mechanical Data

Symb.		mm			inches		
Symb.	Тур.	Min.	Max.	Тур.	Min.	Max.	
A		2.35	2.65		0.093	0.104	
A1		0.10	0.30		0.004	0.012	
В		0.33	0.51		0.013	0.020	
С		0.23	0.32		0.009	0.013	
D		10.10	10.50		0.398	0.413	
E		7.40	7.60		0.291	0.299	
е	1.27	-	-	0.050	-	-	
н		10.00	10.65		0.394	0.419	
h		0.25	0.75		0.010	0.030	
L		0.40	1.27		0.016	0.050	
q		0	8		0	8	
ddd			0.10			0.004	



PART NUMBERING

Table 15. Ordering Information Scheme

Example:	M45PE80	-	V	MP	6 	T I	P
Device Type							
M45PE = Page-Erasable Serial Flash Memory							
Device Function							
80 = 8Mbit (1M x 8)							
Operating Voltage							
$V = V_{CC} = 2.7$ to 3.6V							
Package							
MF = SO16 (300 mil width)							
MP = VDFPN8 6x5mm (MLP8)							
Device Grade							
6 = Industrial temperature range, -40 to 85 °C.							
Device tested with standard test flow							
Option							
blank = Standard Packing							
T = Tape & Reel Packing							
Plating Technology							

blank = Standard SnPb plating P¹ = Lead-Free and RoHS compliant

 G^2 = Lead-Free, RoHS compliant, Sb₂O₃-free and TBBA-free

Note: 1. Available for SO16 package only

2. Available for MLP package only

For a list of available options (speed, package, etc.) or for further information on any aspect of this

device, please contact your nearest ST Sales Office.

REVISION HISTORY

Date	Version	Description of Revision
10-Feb-2003	1.0	Document written
02-Apr-2003	1.1	VFQFPN8 (MLP) package added
08-Apr-2003	1.2	Document promoted to Product Preview
05-May-2003	1.3	Document promoted to Preliminary Data
04-Jun-2003	1.4	Description corrected of entering Hardware Protected mode (\overline{W} must be driven, and cannot be left unconnected). Document Revision History for 05-May-2003 corrected.
26-Nov-2003	2.0	$V_{\text{IO}}(\text{min})$ extended to –0.6V, and $t_{\text{PP}}(\text{typ})$ improved to 1.2ms. Table of contents, SO16 package, warning about exposed paddle on MLP8, and Pb-free options added. Change of naming for VDFPN8 package. Document promoted to full datasheet
23-Jan-2004	3.0	SO16 pin-out corrected
28-May-2004	4.0	Soldering temperature information clarified for RoHS compliant devices. Device Grade clarified

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